## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10824434	YOON ET AL.
Examiner	Art Unit
Tan Alvin H	2173

|--|

SEARCHED			
Class	Subclass	Date	Examiner
715	744, 747	5/3/07 (Updated 6/19/10)	/AT/ (/AT/)

SEARCH NOTES		
Search Notes	Date	Examiner
715/745, 746 (text search only - see search history printout)	5/3/07 (Updated 6/19/10)	/AT/ (/AT/)
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search	5/3/07 (Updated	/AT/ (/AT/)
History Printout	6/19/10)	
NPL - ACM Portal	5/4/07	AT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20100619